	Application/Control No.	Applicant(s)/Patent Under Reexamination
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	Examiner	Art Unit
	Bui-Pho, Pascal M	2878

		ORIGINAL	AL	INTERNA	INTERNATIONAL CLASSIFICATION	
	CLASS		SUBCLASS	CLAIMED	NON-C	NON-CLAIMED
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Pascal M. Bui-Pho	ho 05/03/2007	/2007		11	Total Clain	Total Claims Allowed:
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